



Sample &

Buy





Tools &



**CSD19505KTT** 

UNIT

V

nC

nC

mΩ

mΩ

V

SLPS587 - MARCH 2016

2.9

2.6

# CSD19505KTT 80 V N-Channel NexFET™ Power MOSFET

V<sub>DS</sub>

Qg

 $Q_{gd}$ 

R<sub>DS(on)</sub>

V<sub>GS(th)</sub>

#### Features 1

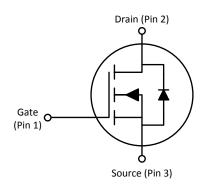
- Ultra-Low Q<sub>a</sub> and Q<sub>ad</sub>
- Low Thermal Resistance
- Avalanche Rated
- **Pb-Free Terminal Plating**
- **RoHS** Compliant
- Halogen Free
- D<sup>2</sup>PAK Plastic Package

#### Applications 2

- Secondary Side Synchronous Rectifier
- Motor Control

#### Description 3

This 80-V, 2.6-mΩ, D<sup>2</sup>PAK (TO-263) NexFET™ power MOSFET is designed to minimize losses in power conversion applications.



#### $T_A = 25^{\circ}C$ TYPICAL VALUE Drain-to-Source Voltage 80 Gate Charge Total (10 V) 76 Gate Charge Gate to Drain 11

## Device Information<sup>(1)</sup>

 $V_{GS} = 6 V$ 

V<sub>GS</sub> = 10 V

2.6

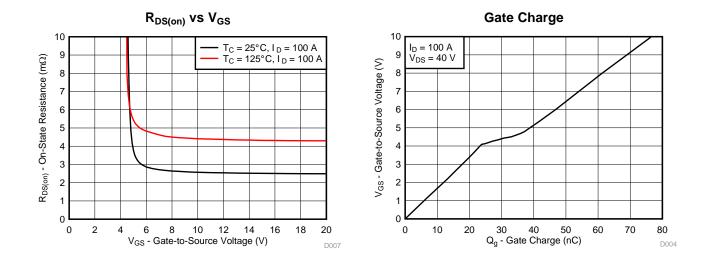
DEVICE	QTY	MEDIA	PACKAGE	SHIP
CSD19505KTT	500	13-Inch D <sup>2</sup> DAK Disatis Dashara		Tape &
CSD19505KTTT	50	Reel	D <sup>2</sup> PAK Plastic Package	Reel

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### **Absolute Maximum Ratings**

T <sub>A</sub> = 2	5°C	VALUE	UNIT
$V_{\text{DS}}$	Drain-to-Source Voltage	80	V
$V_{GS}$	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package Limited)	200	А
I <sub>D</sub>	Continuous Drain Current (Silicon Limited), $T_C = 25^{\circ}C$	212	А
	Continuous Drain Current (Silicon Limited), $T_{C} = 100^{\circ}C$	150	А
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup>	400	А
PD	Power Dissipation	300	W
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction, Storage Temperature	-55 to 175	°C
E <sub>AS</sub>	Avalanche Energy, Single Pulse I_D = 101 A, L = 0.1 mH, R_G = 25 $\Omega$	510	mJ

(1) Max  $R_{\theta JC} = 0.5^{\circ}C/W$ , pulse duration  $\leq 100 \ \mu s$ , duty cycle  $\leq 1\%$ .



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

**Product Summary** 

Drain-to-Source On Resistance

Threshold Voltage



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# 4 Revision History

DATE	REVISION	NOTES
March 2016	*	Initial release.

# **5** Specifications

# 5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS		i		
BV <sub>DSS</sub>	Drain-to-source voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	80		V
I <sub>DSS</sub>	Drain-to-source leakage current	$V_{GS} = 0 V, V_{DS} = 64 V$		1	μA
I <sub>GSS</sub>	Gate-to-source leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V		100	nA
V <sub>GS(th)</sub>	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	2.2 2.6	3.2	V
Р	Drain to course on registerios	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 100 A	2.9	3.8	mΩ
R <sub>DS(on)</sub>	Drain-to-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 100 A	2.6	3.1	mΩ
9 <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 8 V, I <sub>D</sub> = 100 A	262		S
DYNAMI	C CHARACTERISTICS		·		
C <sub>iss</sub>	Input capacitance		6090	7920	pF
C <sub>oss</sub>	Output capacitance	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V, <i>f</i> = 1 MHz	1600	2080	pF
C <sub>rss</sub>	Reverse transfer capacitance		26	34	pF
R <sub>G</sub>	Series gate resistance		1.4	2.8	Ω
Qg	Gate charge total (10 V)		76		nC
Q <sub>gd</sub>	Gate charge gate-to-drain		11		nC
Q <sub>gs</sub>	Gate charge gate-to-source	$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 100 \text{ A}$	25		nC
Q <sub>g(th)</sub>	Gate charge at V <sub>th</sub>		15		nC
Q <sub>oss</sub>	Output charge	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	214		nC
t <sub>d(on)</sub>	Turn on delay time		11		ns
t <sub>r</sub>	Rise time	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 10 V,	5		ns
t <sub>d(off)</sub>	Turn off delay time	$I_{\rm DS} = 100 \text{ A}, \text{ R}_{\rm G} = 0 \Omega$	22		ns
t <sub>f</sub>	Fall time		3		ns
DIODE C	CHARACTERISTICS				
V <sub>SD</sub>	Diode forward voltage	I <sub>SD</sub> = 100 A, V <sub>GS</sub> = 0 V	0.9	1.1	V
Q <sub>rr</sub>	Reverse recovery charge	$V_{DS} = 40 \text{ V}, \text{ I}_{\text{F}} = 100 \text{ A},$	400		nC
t <sub>rr</sub>	Reverse recovery time	$di/dt = 300 \text{ A}/\mu\text{s}$	88		ns

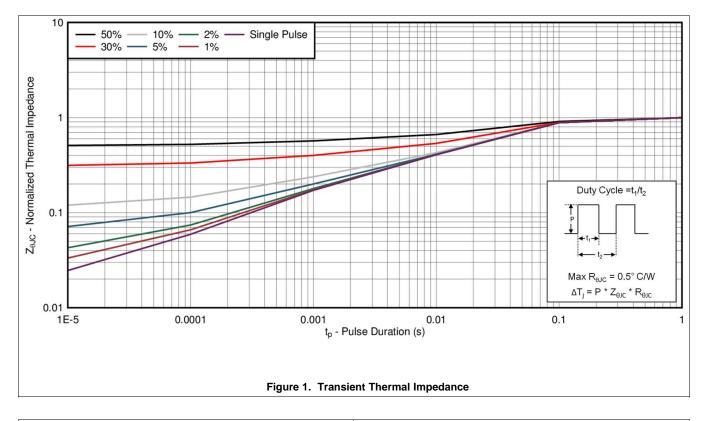
## 5.2 Thermal Information

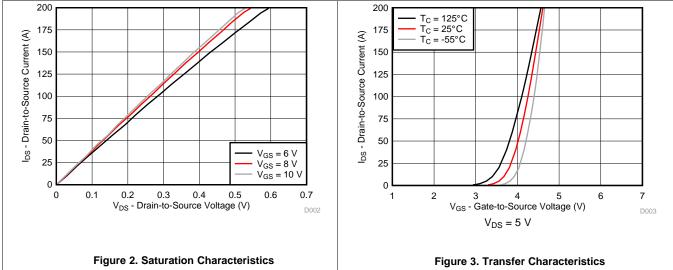
( $T_A = 25^{\circ}C$  unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.5	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	°C/W

# 5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 



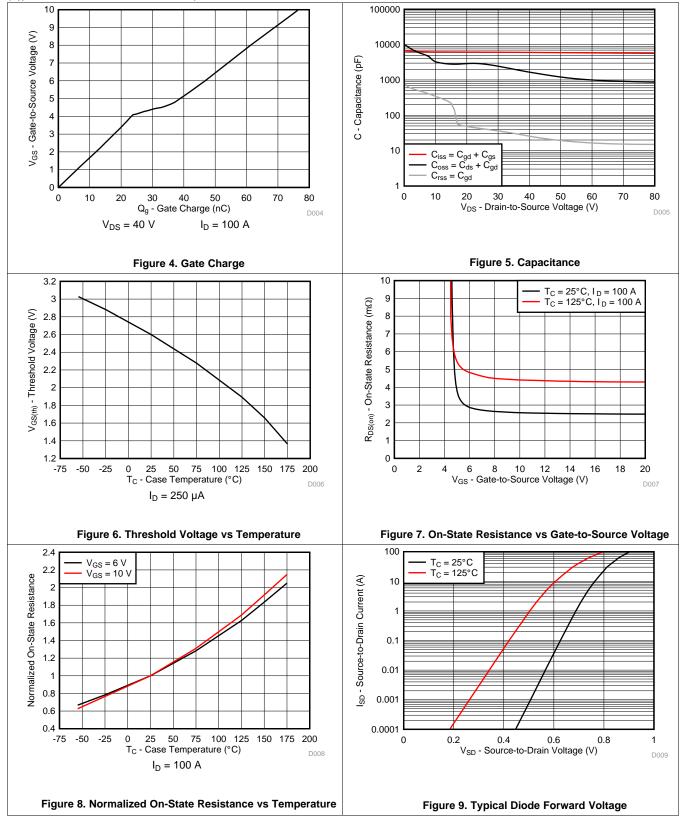


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## **Typical MOSFET Characteristics (continued)**

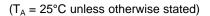
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

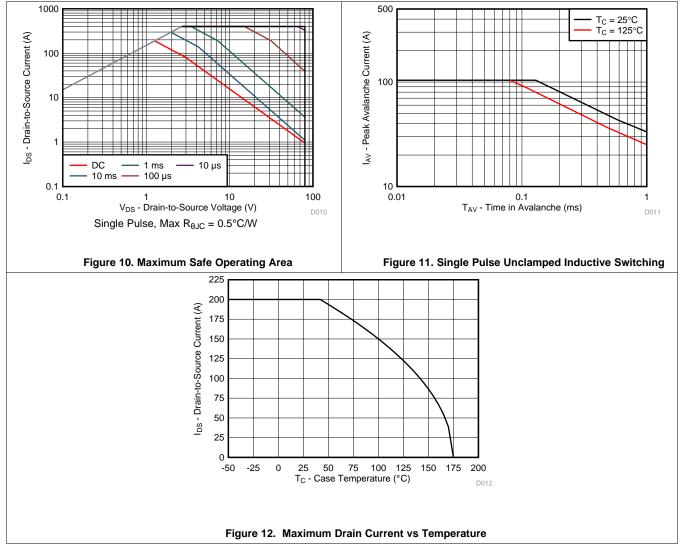




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# **Typical MOSFET Characteristics (continued)**







## 6 Device and Documentation Support

### 6.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E<sup>™</sup> Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

## 6.2 Trademarks

NexFET, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

### 6.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 6.4 Glossary

SLYZ022 — TI Glossary.

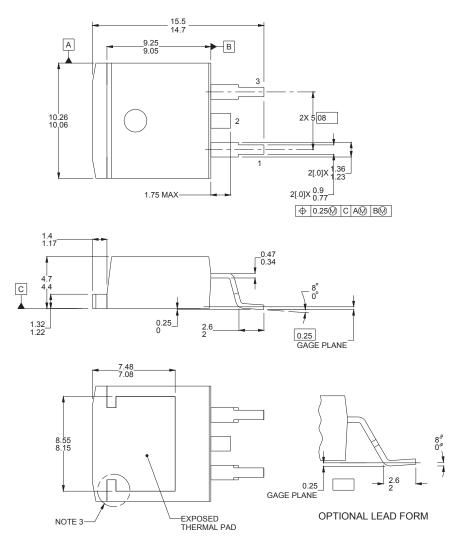
This glossary lists and explains terms, acronyms, and definitions.



## 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## 7.1 KTT Package Dimensions



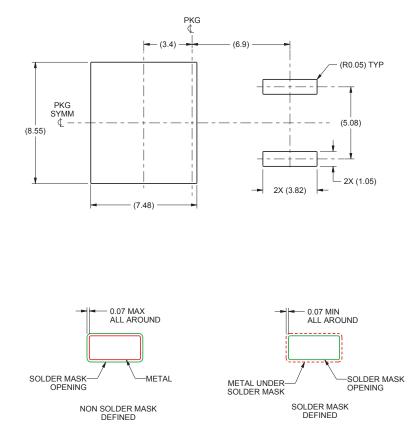
### Notes:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. Features may not exist and shape may vary per different assembly sites.

Pin Configuration								
POSITION	DESIGNATION							
Pin 1	Gate							
Pin 2 / Tab	Drain							
Pin 3	Source							

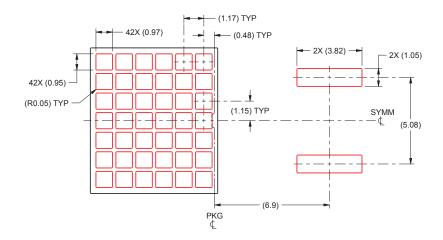


## 7.2 Recommended PCB Pattern



For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

### 7.3 Recommended Stencil Opening (0.125 mm Stencil Thickness)



#### Notes:

- 1. This package is designed to be soldered to a thermal pad on the board. See application notes, *PowerPAD Thermally Enhanced Package* (SLMA002) and *PowerPAD Made Easy* (SLMA004) for more information.
- 2. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 3. Board assembly site may have different recommendations for stencil design.



10-Dec-2020

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CSD19505KTT	ACTIVE	DDPAK/ TO-263	КТТ	3	500	RoHS-Exempt & Green	SN	Level-2-260C-1 YEAR	-55 to 175	CSD19505KTT	Samples
CSD19505KTTT	ACTIVE	DDPAK/ TO-263	КТТ	3	50	RoHS-Exempt & Green	SN	Level-2-260C-1 YEAR	-55 to 175	CSD19505KTT	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM

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